



TFW 2621

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicant:	Yuan-Ku Lan	)	Examiner:	Hadi Akhavannik
Serial No.	10/086,928	)	Art Unit:	2621
Filed:	February 28, 2002	)	Our Ref:	B-4514 619559-4
For:	"METHOD OF CHECKING OVERLAP ACCURACY..."	)	Date:	December 29, 2005
		)	Re:	<i>Response</i>

**RESPONSE**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

This paper is filed in response to the Official action dated October 5, 2005.

Specification amendments begin on page 2 of this response while claim amendments begin on page 7. Applicant's remarks can be found starting at page 15.